Notice of References Cited					Application/Control No. Applicant(Reexamin LEE ET A)/Patent Under ation	
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					Chandra Cl	naudhari	2891	Page 1 of 1	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY			Classification			
*	Α	US-6,248,633	06-2001	Ogura	 et al.	438/267			
*	В	US-6,531,350	03-2003	Satoh et al.				438/197	
*	С	US-6,670,240	12-2003	Ogura et al.				438/257	
	D	US-			<u> </u>				
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NON-PATENT DOCUMENTS									
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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